Index of Claims

Application/Control No.	Applicant(s)/Patent Under Reexamination
10617901	DUNKLE, MARK VANDEVERT
Examiner	Art Unit
Saeed, Usmaan	2166

✓	Rejected	•	Cancelled
=	Allowed	÷	Restricted

	N	Non-Elected
	ı	Interference

Α	Appeal
0	Objected

CL	AIM	DATE										
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	1	√	√	√	✓	√						+
	2	-	-		-	-						+
	3	-		-	-	-						+
	4	√	√	√	√	√						+
	5	√	√	✓	✓	✓						1
	6	√	✓	✓	✓	√					-	+
	7	-	-	-	-	-					-	\top
	8	√	✓	✓	✓	√					-	\top
	9	√	✓	✓	✓	√						1
	10	-	-	-	-	-						1
	11	-	-	-	-	-						1
	12	-	-	-	-	-						\top
	13	-	-	-	-	-						\top
	14	-	-	-	-	-						
	15	✓	✓	✓	✓	✓						\top
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	35	-	-	-	-	-						

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☐ Claims renumbered in the same order as presented by applicant ☐ CPA ☐ T.D. ☐ R.1.47									D R.1.47

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Final	Original	12/05/2007	06/24/2008	12/04/2008	10/12/2009	04/05/2010						
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	43	-	-	-	-	-						
	44	✓	✓	✓	✓	✓						
	45	√	✓	✓	✓	✓						
	46	✓	✓	✓	✓	✓						
	47	√	✓	✓	✓	✓						
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	54		✓	✓	✓	✓						
	55				✓	✓						
	56				✓	✓						

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